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Applied Surface Science 205 (2003) I–IV

applied surface science

www.elsevier.com/locate/apsusc

Author Index

Ammendola, G., see Nicotra, G. 205 (2003) 304
Arcoya, A., X.L. Seoane and J.M. Grau, Surface characterization and dehydrocyclization activity of Pt/KL catalysts prepared by different methods 205 (2003) 206
Atalar, A., see Balantekin, M. 205 (2003) 86
Ay, M., A. Nefedov and H. Zabel, Growth properties and structural analysis of ZnO films and of Au clusters on ZnO 205 (2003) 329

Bailey, P., see Garcia-Vergara, S. 205 (2003) 121
Balantekin, M., and A. Atalar, Simulations of switching vibrating cantilever in atomic force microscopy 205 (2003) 86
Bassim, N., V. Craciun, J. Howard and R.K. Singh, Effect of silicon pre-nitridation on the formation of the interfacial layer during pulsed laser deposition of thin dielectric oxide films 205 (2003) 267
Bernède, J.C., see El Maliki, H. 205 (2003) 65
Borchardt, G., see Chevalier, S. 205 (2003) 188

Castel, X., see El Maliki, H. 205 (2003) 65
Castro-Rodríguez, R., see Oliva, A.I. 205 (2003) 56
Cha, D., see E, J. 205 (2003) 274
Chan, K., see Yip, J. 205 (2003) 151
Chaudhari, S.M., see Gupta, M. 205 (2003) 309
Chen, K., see Zhang, Y. 205 (2003) 256
Chen, R., see Swart, H.C. 205 (2003) 231
Chevalier, S., M. Kilo, G. Borchardt and J.P. Larpin, MOCVD deposition of YSZ on stainless steels 205 (2003) 188
Chung, Y.-D., see Lee, W.-J. 205 (2003) 128
Ci, L., H. Zhu, B. Wei, C. Xu and D. Wu, Annealing amorphous carbon nanotubes for their application in hydrogen storage 205 (2003) 39
Claassens, C.H., see Swart, H.C. 205 (2003) 231
Coddet, C., see Verdier, M. 205 (2003) 3
Costil, S., see Verdier, M. 205 (2003) 3
Craciun, V., see Bassim, N. 205 (2003) 267
Craig Jr., J.H., see Davies, B.M. 205 (2003) 22
Cultrera, L., see Perrone, A. 205 (2003) 1

Dąbrowski, A., see Podkościelny, P. 205 (2003) 297
Dasannacharya, B.A., see Gupta, M. 205 (2003) 309
Dauchot, J.-P., see Vancoppenolle, V. 205 (2003) 249
Davies, B.M., and J.H. Craig Jr., NO adsorption on Ge(1 0 0) studied by TPD 205 (2003) 22
Delhalle, J., see Forget, L. 205 (2003) 44
Demuro, C., see Nicotra, G. 205 (2003) 304
Ding, Z., see Pan, A. 205 (2003) 323
Duffet, G., P. Sallamand and A.B. Vannes, Improvement in friction by cw Nd:YAG laser surface treatment on cast iron cylinder bore 205 (2003) 289
Dumitru, G., V. Romano, H.P. Weber, M. Sentis and W. Marine, Ablation of carbide materials with femtosecond pulses 205 (2003) 80

E, J., S. Kim, E. Lim, K. Lee, D. Cha and B. Friedman, Effects of substrate temperature on copper(II) phthalocyanine thin films 205 (2003) 274
El Maliki, H., J.C. Bernède, S. Marsillac, J. Pinel, X. Castel and J. Pouzet, Study of the influence of annealing on the properties of CBD-CdS thin films 205 (2003) 65
Evangelakis, G.A., see Lekka, Ch.E. 205 (2003) 280

Falk, F., see Hedler, A. 205 (2003) 240
Forget, L., F. Wilwers, J. Delhalle and Z. Mekhalif, Surface modification of aluminum by *n*-pentanephosphonic acid: XPS and electrochemical evaluation 205 (2003) 44
Forleo, A., see Perrone, A. 205 (2003) 1
Friedman, B., see E, J. 205 (2003) 274
Fu, D., see Zhang, Y. 205 (2003) 256
Fujita, D., see Xu, M. 205 (2003) 225

Gaković, B.M., see Trtica, M.S. 205 (2003) 336
Garcia-Vergara, S., P. Skeldon, G.E. Thompson, P. Bailey, T.C.Q. Noakes, H. Habazaki and K. Shimizu, Morphology of enriched alloy layers in an anodized Al–Cu alloy 205 (2003) 121
Gerardi, C., see Nicotra, G. 205 (2003) 304
Grau, J.M., see Arcoya, A. 205 (2003) 206
Gu, N., see Zhang, Y. 205 (2003) 256
Guido, D., see Perrone, A. 205 (2003) 1
Gupta, A., see Gupta, M. 205 (2003) 309
Gupta, M., A. Gupta, D.M. Phase, S.M. Chaudhari and B.A. Dasannacharya, Development of an ion-beam sputtering system for depositing thin films and multilayers of alloys and compounds 205 (2003) 309

Habazaki, H., see Garcia-Vergara, S. 205 (2003) 121
Hagelin, H.A.E., see Hoflund, G.B. 205 (2003) 102

PII: S0169-4332(02)01320-X

Hatano, T., see Xu, M. 205 (2003) 225
Hecq, M., see Vancoppenolle, V. 205 (2003) 249
Hedler, A., S. Urban, F. Falk, H. Hobert and W. Wesch, Excimer laser crystallization of amorphous silicon carbide produced by ion implantation 205 (2003) 240
Hobert, H., see Hedler, A. 205 (2003) 240
Hoflund, G.B., H.A.E. Hagelin, J.F. Weaver and G.N. Salaita, ELS and XPS study of Pd/PdO methane oxidation catalysts 205 (2003) 102
Howard, J., see Bassim, N. 205 (2003) 267
Hu, H., see Lu, F. 205 (2003) 262

Jesionowski, T., J. Żurawska, A. Krysztafkiewicz, M. Pokora, D. Waszak and W. Tylus, Physicochemical and morphological properties of hydrated silicas precipitated following alkoxysilane surface modification 205 (2003) 212
Jonker, A.J., see Swart, H.C. 205 (2003) 231
Jouan, P.-Y., see Vancoppenolle, V. 205 (2003) 249

Kilo, M., see Chevalier, S. 205 (2003) 188
Kim, D.S., and C.K. Lee, Erratum to "Surface modification of precipitated calcium carbonate using aqueous fluosilicic acid". [Applied Surface Science 202/1-2 (2002) 15–23] 205 (2003) 2
Kim, S., see E, J. 205 (2003) 274
Kimura, T., see Xu, M. 205 (2003) 225
Korotchenkov, G., see Skála, T. 205 (2003) 196
Kriven, W.M., see Schreckenbach, J.P. 205 (2003) 97
Krysztafkiewicz, A., see Jesionowski, T. 205 (2003) 212
Kulka, M., see Pertek, A. 205 (2003) 137
Kürşad Balci, E., see Sari, B. 205 (2003) 27

Lamperti, A., and P.M. Ossi, Systematic study of amorphous hydrogenated and fluorinated carbon films 205 (2003) 113
Larpin, J.P., see Chevalier, S. 205 (2003) 188
Lau, K.S., see Yip, J. 205 (2003) 151
Lee, B.T., see Schreckenbach, J.P. 205 (2003) 97
Lee, C.K., see Kim, D.S. 205 (2003) 2
Lee, K., see E, J. 205 (2003) 274
Lee, W.-J., Y.-S. Lee, S.-K. Rha, Y.-J. Lee, K.-Y. Lim, Y.-D. Chung and C.-N. Whang, Adhesion and interface chemical reactions of Cu/polyimide and Cu/TiN by XPS 205 (2003) 128
Lee, Y.-J., see Lee, W.-J. 205 (2003) 128
Lee, Y.-S., see Lee, W.-J. 205 (2003) 128
Lekka, Ch.E., and G.A. Evangelakis, Vacancy diffusion driven surface rearrangement in the $Cu_3Au(0\,0\,1)$ and $Ni_3Al(0\,0\,1)$ surfaces 205 (2003) 280
Lezal, D., see Messaddeq, S.H. 205 (2003) 143
Lim, E., see E, J. 205 (2003) 274
Lim, K.-Y., see Lee, W.-J. 205 (2003) 128
Liu, F., see Pan, A. 205 (2003) 323
Liu, J., see Zhang, Y. 205 (2003) 256
Liu, P., see Ying, M. 205 (2003) 182
Liu, X., see Ying, M. 205 (2003) 182
Liu, Z.G., see Wang, Y.P. 205 (2003) 176
Lombardo, S., see Nicotra, G. 205 (2003) 304
Lu, F., H. Hu and A. Rizzi, Lattice damage induced by Tb-implanted AlN crystalline films 205 (2003) 262
Lu, X.B., see Wang, Y.P. 205 (2003) 176
Lu, Z., see Zhang, Y. 205 (2003) 256

Ma, M., see Zhang, Y. 205 (2003) 256
Ma, Y., see Zhang, Y. 205 (2003) 256
Marijuk, O.V., see Podkościelny, P. 205 (2003) 297
Marine, W., see Dumitru, G. 205 (2003) 80
Marsillac, S., see El Maliki, H. 205 (2003) 65
Marx, G., see Schreckenbach, J.P. 205 (2003) 97
Mastelaro, V.R., see Messaddeq, S.H. 205 (2003) 143
Matolín, V., see Skála, T. 205 (2003) 196
Matolínová, I., see Skála, T. 205 (2003) 196
Mekhalif, Z., see Forget, L. 205 (2003) 44
Messaddeq, S.H., V.R. Mastelaro, M. Siu Li, M. Tabackniks, D. Lezal, A. Ramos and Y. Messaddeq, The influence of oxygen in the photoexpansion of GaGeS glasses 205 (2003) 143
Messaddeq, Y., see Messaddeq, S.H. 205 (2003) 143
Meyer, N., see Schreckenbach, J.P. 205 (2003) 97
Moroseac, M., see Skála, T. 205 (2003) 196

Nefedov, A., see Ay, M. 205 (2003) 329
Nicotra, G., S. Lombardo, C. Spinella, G. Ammendola, C. Gerardi and C. Demuro, Observation of the nucleation kinetics of Si quantum dots on SiO_2 by energy filtered transmission electron microscopy 205 (2003) 304
Noakes, T.C.Q., see Garcia-Vergara, S. 205 (2003) 121

Oliva, A.I., R. Castro-Rodríguez, O. Solís-Canto, V. Sosa, P. Quintana and J.L. Peña, Comparison of properties of CdS thin films grown by two techniques 205 (2003) 56
Oltra, R., see Verdier, M. 205 (2003) 3
Ossi, P.M., see Lamperti, A. 205 (2003) 113

Pan, A., Z. Yang, H. Zheng, F. Liu, Y. Zhu, X. Su and Z. Ding, Changeable position of SPR peak of Ag nanoparticles embedded in mesoporous SiO_2 glass by annealing treatment 205 (2003) 323
Pan, J., see Ying, M. 205 (2003) 182
Peña, J.L., see Oliva, A.I. 205 (2003) 56
Perret, O., see Verdier, M. 205 (2003) 3
Perrone, A., A. Zocco, L. Cultrera, D. Guido and A. Forleo, Erratum to "Detailed studies of the plume deflection effect during long laser irradiation of solid targets". [Applied Surface Science 197-198 (2002) 251–256] 205 (2003) 1
Pertek, A., and M. Kulka, Characterization of single tracks after laser surface modification of borided 41Cr4 steel 205 (2003) 137
Phase, D.M., see Gupta, M. 205 (2003) 309
Pinel, J., see El Maliki, H. 205 (2003) 65

Podkościelny, P., A. Dąbrowski and O.V. Marijuk, Heterogeneity of active carbons in adsorption of phenol aqueous solutions 205 (2003) 297
Pokora, M., see Jesionowski, T. 205 (2003) 212
Pouzet, J., see El Maliki, H. 205 (2003) 65
Perrone, A., A. Zocco, L. Cultrera and D. Guido, Ettatum to " Detailed studies of the plume deflection effect during long laser irradiation of solid targets. [Applied Surface Science 197–198 (2002) 251–256] 205 (2003) 1

Quintana, P., see Oliva, A.I. 205 (2003) 56

Raghu, P., see Rana, N. 205 (2003) 160
Ramos, A., see Messaddeq, S.H. 205 (2003) 143
Ramoshebe, P., see Swart, H.C. 205 (2003) 231
Rana, N., P. Raghu, E. Shero and F. Shadman, Interactions of moisture and organic contaminants with SiO_2 and ZrO_2 gate dielectric films 205 (2003) 160
Rha, S.-K., see Lee, W.-J. 205 (2003) 128
Ricard, A., see Vancoppenolle, V. 205 (2003) 249
Rizzi, A., see Lu, F. 205 (2003) 262
Romano, V., see Dumitru, G. 205 (2003) 80
Roos, W.D., see Swart, H.C. 205 (2003) 231

Salaita, G.N., see Hoflund, G.B. 205 (2003) 102
Sallamand, P., see Duffet, G. 205 (2003) 289
Sari, B., M. Talu, F. Yildirim and Kürşad Balci E., Synthesis and characterization of polyurethane/polythiophene conducting copolymer by electrochemical method 205 (2003) 27
Schreckenbach, J.P., N. Meyer, G. Marx, B.T. Lee and W.M. Kriven, Strontium hafnate phases by anodic spark conversion 205 (2003) 97
Sentis, M., see Dumitru, G. 205 (2003) 80
Seoane, X.L., see Arcoya, A. 205 (2003) 206
Shadman, F., see Rana, N. 205 (2003) 160
Shero, E., see Rana, N. 205 (2003) 160
Shimizu, K., see Garcia-Vergara, S. 205 (2003) 121
Sin, K.M., see Yip, J. 205 (2003) 151
Singh, R.K., see Bassim, N. 205 (2003) 267
Siu Li, M., see Messaddeq, S.H. 205 (2003) 143
Skála, T., K. Veltruská, M. Moroseac, I. Matolínová, G. Korotchenkov and V. Matolín, Study of Pd–In interaction during Pd deposition on pyrolytically prepared In_2O_3 205 (2003) 196
Skeldon, P., see Garcia-Vergara, S. 205 (2003) 121
Solís-Canto, O., see Oliva, A.I. 205 (2003) 56
Sosa, V., see Oliva, A.I. 205 (2003) 56
Spinella, C., see Nicotra, G. 205 (2003) 304
Stamate, M.D., On the non-linear *I–V* characteristics of dc magnetron sputtered TiO_2 thin films 205 (2003) 353
Su, X., see Pan, A. 205 (2003) 323
Sun, Y., see Ying, M. 205 (2003) 182
Swart, H.C., A.J. Jonker, C.H. Claassens, R. Chen, L.A. Venter, P. Ramoshebe, E. Wurth, J.J. Terblans and W.D. Roos, Extracting inter-diffusion parameters of TiC from AES depth profiles 205 (2003) 231

Tabackniks, M., see Messaddeq, S.H. 205 (2003) 143
Takano, Y., see Xu, M. 205 (2003) 225
Talu, M., see Sari, B. 205 (2003) 27
Terblans, J.J., see Swart, H.C. 205 (2003) 231
Thompson, G.E., see Garcia-Vergara, S. 205 (2003) 121
Trtica, M.S., and B.M. Gaković, Pulsed TEA CO_2 laser surface modifications of silicon 205 (2003) 336
Tylus, W., see Jesionowski, T. 205 (2003) 212

Urban, S., see Hedler, A. 205 (2003) 240

Vancoppenolle, V., P.-Y. Jouan, A. Ricard, M. Wautelet, J.-P. Dauchot and M. Hecq, Oxygen active species in an Ar–O_2 magnetron discharge for titanium oxide deposition 205 (2003) 249
Vannes, A.B., see Duffet, G. 205 (2003) 289
Veltruská, K., see Skála, T. 205 (2003) 196
Venter, L.A., see Swart, H.C. 205 (2003) 231
Verdier, M., S. Costil, C. Coddet, R. Oltra and O. Perret, On the topographic and energetic surface modifications induced by laser treatment of metallic substrates before plasma spraying 205 (2003) 3

Wang, X., see Zhang, Y. 205 (2003) 256
Wang, Y.P., L. Zhou, X.B. Lu and Z.G. Liu, *C–V* characteristics of Pt/$PbZr_{0.53}Ti_{0.47}O_3$/$LaAlO_3$/Si and Pt/$PbZr_{0.53}Ti_{0.47}O_3$/$La_{0.85}Sr_{0.15}CoO_3$/$LaAlO_3$/Si structures for ferroelectric gate FET memory 205 (2003) 176
Waszak, D., see Jesionowski, T. 205 (2003) 212
Wautelet, M., see Vancoppenolle, V. 205 (2003) 249
Weaver, J.F., see Hoflund, G.B. 205 (2003) 102
Weber, H.P., see Dumitru, G. 205 (2003) 80
Wei, B., see Ci, L. 205 (2003) 39
Wesch, W., see Hedler, A. 205 (2003) 240
Whang, C.-N., see Lee, W.-J. 205 (2003) 128
Wilwers, F., see Forget, L. 205 (2003) 44
Wu, D., see Ci, L. 205 (2003) 39
Wurth, E., see Swart, H.C. 205 (2003) 231

Xia, Y., see Ying, M. 205 (2003) 182
Xiao, S., see Ying, M. 205 (2003) 182
Xu, C., see Ci, L. 205 (2003) 39
Xu, L., see Zhang, Y. 205 (2003) 256
Xu, M., Y. Takano, T. Hatano, T. Kimura and D. Fujita, Auger electron spectroscopy study of MgB_2 surface 205 (2003) 225

Yang, Z., see Pan, A. 205 (2003) 323
Yildirim, F., see Sari, B. 205 (2003) 27
Ying, M., P. Liu, Y. Xia, X. Liu, M. Zhao, S. Xiao, Y. Sun and J. Pan, Investigation of intermixing induced by sputtering and annealing in multiple quantum well 205 (2003) 182
Yip, J., K. Chan, K.M. Sin and K.S. Lau, Study on the surface chemical properties of UV excimer laser irradiated polyamide by XPS, ToF-SIMS and CFM 205 (2003) 151

Zabel, H., see Ay, M. 205 (2003) 329

Zhang, J., X. Zhang and H. Zhou, Effect of aging on surface chemical bonds of PTFE irradiated by low energy Ti ion 205 (2003) 343
Zhang, X., see Zhang, J. 205 (2003) 343
Zhang, Y., X. Wang, M. Ma, D. Fu, N. Gu, J. Liu, Z. Lu, Y. Ma, L. Xu and K. Chen, Influence of surface-capping molecule exchange on the hyper-Rayleigh scattering of CdS nanoparticles 205 (2003) 256
Zhao, M., see Ying, M. 205 (2003) 182
Zheng, H., see Pan, A. 205 (2003) 323
Zhou, H., see Zhang, J. 205 (2003) 343
Zhou, L., see Wang, Y.P. 205 (2003) 176
Zhu, H., see Ci, L. 205 (2003) 39
Zhu, Y., see Pan, A. 205 (2003) 323
Zocco, A., see Perrone, A. 205 (2003) 1
Żurawska, J., see Jesionowski, T. 205 (2003) 212

ELSEVIER

Applied Surface Science 205 (2003) V–X

applied surface science

www.elsevier.com/locate/apsusc

Subject Index

Ablation

Ablation of carbide materials with femtosecond pulses, G. Dumitru, V. Romano, H.P. Weber, M. Sentis and W. Marine 205 (2003) 80

Aluminium

Investigation of intermixing induced by sputtering and annealing in multiple quantum well, M. Ying, P. Liu, Y. Xia, X. Liu, M. Zhao, S. Xiao, Y. Sun and J. Pan 205 (2003) 182

Annealing

Annealing amorphous carbon nanotubes for their application in hydrogen storage, L. Ci, H. Zhu, B. Wei, C. Xu and D. Wu 205 (2003) 39

Investigation of intermixing induced by sputtering and annealing in multiple quantum well, M. Ying, P. Liu, Y. Xia, X. Liu, M. Zhao, S. Xiao, Y. Sun and J. Pan 205 (2003) 182

Changeable position of SPR peak of Ag nanoparticles embedded in mesoporous SiO_2 glass by annealing treatment, A. Pan, Z. Yang, H. Zheng, F. Liu, Y. Zhu, X. Su and Z. Ding 205 (2003) 323

Arsenic

Investigation of intermixing induced by sputtering and annealing in multiple quantum well, M. Ying, P. Liu, Y. Xia, X. Liu, M. Zhao, S. Xiao, Y. Sun and J. Pan 205 (2003) 182

Atomic force microscopy

Comparison of properties of CdS thin films grown by two techniques, A.I. Oliva, R. Castro-Rodríguez, O. Solís-Canto, V. Sosa, P. Quintana and J.L. Peña 205 (2003) 56

Ablation of carbide materials with femtosecond pulses, G. Dumitru, V. Romano, H.P. Weber, M. Sentis and W. Marine 205 (2003) 80

Adhesion and interface chemical reactions of Cu/polyimide and Cu/TiN by XPS, W.-J. Lee, Y.-S. Lee, S.-K. Rha, Y.-J. Lee, K.-Y. Lim, Y.-D. Chung and C.-N. Whang 205 (2003) 128

Growth properties and structural analysis of ZnO films and of Au clusters on ZnO, M. Ay, A. Nefedov and H. Zabel 205 (2003) 329

Auger electron spectroscopy

Comparison of properties of CdS thin films grown by two techniques, A.I. Oliva, R. Castro-Rodríguez, O. Solís-Canto, V. Sosa, P. Quintana and J.L. Peña 205 (2003) 56

Adhesion and interface chemical reactions of Cu/polyimide and Cu/TiN by XPS, W.-J. Lee, Y.-S. Lee, S.-K. Rha, Y.-J. Lee, K.-Y. Lim, Y.-D. Chung and C.-N. Whang 205 (2003) 128

Extracting inter-diffusion parameters of TiC from AES depth profiles, H.C. Swart, A.J. Jonker, C.H. Claassens, R. Chen, L.A. Venter, P. Ramoshebe, E. Wurth, J.J. Terblans and W.D. Roos 205 (2003) 231

Cadmium sulphide

Comparison of properties of CdS thin films grown by two techniques, A.I. Oliva, R. Castro-Rodríguez, O. Solís-Canto, V. Sosa, P. Quintana and J.L. Peña 205 (2003) 56

Study of the influence of annealing on the properties of CBD-CdS thin films, H. El Maliki, J.C. Bernède, S. Marsillac, J. Pinel, X. Castel and J. Pouzet 205 (2003) 65

Influence of surface-capping molecule exchange on the hyper-Rayleigh scattering of CdS nanoparticles, Y. Zhang, X. Wang, M. Ma, D. Fu, N. Gu, J. Liu, Z. Lu, Y. Ma, L. Xu and K. Chen 205 (2003) 256

Carbides

Ablation of carbide materials with femtosecond pulses, G. Dumitru, V. Romano, H.P. Weber, M. Sentis and W. Marine 205 (2003) 80

PII: S0169-4332(02)01321-1

Carbon

Annealing amorphous carbon nanotubes for their application in hydrogen storage, L. Ci, H. Zhu, B. Wei, C. Xu and D. Wu 205 (2003) 39
Systematic study of amorphous hydrogenated and fluorinated carbon films, A. Lamperti and P.M. Ossi 205 (2003) 113
Heterogeneity of active carbons in adsorption of phenol aqueous solutions, P. Podkościelny, A. Dąbrowski and O.V. Marijuk 205 (2003) 297

Catalysis

ELS and XPS study of Pd/PdO methane oxidation catalysts, G.B. Hoflund, H.A.E. Hagelin, J.F. Weaver and G.N. Salaita 205 (2003) 102

Chemical vapour deposition

Systematic study of amorphous hydrogenated and fluorinated carbon films, A. Lamperti and P.M. Ossi 205 (2003) 113

Clusters

Growth properties and structural analysis of ZnO films and of Au clusters on ZnO, M. Ay, A. Nefedov and H. Zabel 205 (2003) 329

Copper

Adhesion and interface chemical reactions of Cu/polyimide and Cu/TiN by XPS, W.-J. Lee, Y.-S. Lee, S.-K. Rha, Y.-J. Lee, K.-Y. Lim, Y.-D. Chung and C.-N. Whang 205 (2003) 128
Effects of substrate temperature on copper(II) phthalocyanine thin films, J. E, S. Kim, E. Lim, K. Lee, D. Cha and B. Friedman 205 (2003) 274

Depth profiling

Study of the influence of annealing on the properties of CBD-CdS thin films, H. El Maliki, J.C. Bernède, S. Marsillac, J. Pinel, X. Castel and J. Pouzet 205 (2003) 65
Extracting inter-diffusion parameters of TiC from AES depth profiles, H.C. Swart, A.J. Jonker, C.H. Claassens, R. Chen, L.A. Venter, P. Ramoshebe, E. Wurth, J.J. Terblans and W.D. Roos 205 (2003) 231

Electrical properties

On the non-linear *I–V* characteristics of dc magnetron sputtered TiO_2 thin films, M.D. Stamate 205 (2003) 353

Electron diffraction

Strontium hafnate phases by anodic spark conversion, J.P. Schreckenbach, N. Meyer, G. Marx, B.T. Lee and W.M. Kriven 205 (2003) 97
Growth properties and structural analysis of ZnO films and of Au clusters on ZnO, M. Ay, A. Nefedov and H. Zabel 205 (2003) 329

Electron energy loss spectroscopy

ELS and XPS study of Pd/PdO methane oxidation catalysts, G.B. Hoflund, H.A.E. Hagelin, J.F. Weaver and G.N. Salaita 205 (2003) 102

Electron microscopy

On the topographic and energetic surface modifications induced by laser treatment of metallic substrates before plasma spraying, M. Verdier, S. Costil, C. Coddet, R. Oltra and O. Perret 205 (2003) 3
Annealing amorphous carbon nanotubes for their application in hydrogen storage, L. Ci, H. Zhu, B. Wei, C. Xu and D. Wu 205 (2003) 39
Study of the influence of annealing on the properties of CBD-CdS thin films, H. El Maliki, J.C. Bernède, S. Marsillac, J. Pinel, X. Castel and J. Pouzet 205 (2003) 65
Ablation of carbide materials with femtosecond pulses, G. Dumitru, V. Romano, H.P. Weber, M. Sentis and W. Marine 205 (2003) 80
Strontium hafnate phases by anodic spark conversion, J.P. Schreckenbach, N. Meyer, G. Marx, B.T. Lee and W.M. Kriven 205 (2003) 97
Effects of substrate temperature on copper(II) phthalocyanine thin films, J. E, S. Kim, E. Lim, K. Lee, D. Cha and B. Friedman 205 (2003) 274
Changeable position of SPR peak of Ag nanoparticles embedded in mesoporous SiO_2 glass by annealing treatment, A. Pan, Z. Yang, H. Zheng, F. Liu, Y. Zhu, X. Su and Z. Ding 205 (2003) 323
Effect of aging on surface chemical bonds of PTFE irradiated by low energy Ti ion, J. Zhang, X. Zhang and H. Zhou 205 (2003) 343

Evaporation

Extracting inter-diffusion parameters of TiC from AES depth profiles, H.C. Swart,

A.J. Jonker, C.H. Claassens, R. Chen, L.A. Venter, P. Ramoshebe, E. Wurth, J.J. Terblans and W.D. Roos 205 (2003) 231

Gallium

Investigation of intermixing induced by sputtering and annealing in multiple quantum well, M. Ying, P. Liu, Y. Xia, X. Liu, M. Zhao, S. Xiao, Y. Sun and J. Pan 205 (2003) 182

Gold

Growth properties and structural analysis of ZnO films and of Au clusters on ZnO, M. Ay, A. Nefedov and H. Zabel 205 (2003) 329

Hafnia

Strontium hafnate phases by anodic spark conversion, J.P. Schreckenbach, N. Meyer, G. Marx, B.T. Lee and W.M. Kriven 205 (2003) 97

Halogens

Systematic study of amorphous hydrogenated and fluorinated carbon films, A. Lamperti and P.M. Ossi 205 (2003) 113

Hydrocarbons

Heterogeneity of active carbons in adsorption of phenol aqueous solutions, P. Podkościelny, A. Dąbrowski and O.V. Marijuk 205 (2003) 297

Hydrogen

Annealing amorphous carbon nanotubes for their application in hydrogen storage, L. Ci, H. Zhu, B. Wei, C. Xu and D. Wu 205 (2003) 39
Systematic study of amorphous hydrogenated and fluorinated carbon films, A. Lamperti and P.M. Ossi 205 (2003) 113

Ion bombardment

Effect of aging on surface chemical bonds of PTFE irradiated by low energy Ti ion, J. Zhang, X. Zhang and H. Zhou 205 (2003) 343

Indium

Investigation of intermixing induced by sputtering and annealing in multiple quantum well, M. Ying, P. Liu, Y. Xia, X. Liu, M. Zhao, S. Xiao, Y. Sun and J. Pan 205 (2003) 182

Infrared spectroscopy

Study of the influence of annealing on the properties of CBD-CdS thin films, H. El Maliki, J.C. Bernède, S. Marsillac, J. Pinel, X. Castel and J. Pouzet 205 (2003) 65
Systematic study of amorphous hydrogenated and fluorinated carbon films, A. Lamperti and P.M. Ossi 205 (2003) 113

Interfaces

Adhesion and interface chemical reactions of Cu/polyimide and Cu/TiN by XPS, W.-J. Lee, Y.-S. Lee, S.-K. Rha, Y.-J. Lee, K.-Y. Lim, Y.-D. Chung and C.-N. Whang 205 (2003) 128
Investigation of intermixing induced by sputtering and annealing in multiple quantum well, M. Ying, P. Liu, Y. Xia, X. Liu, M. Zhao, S. Xiao, Y. Sun and J. Pan 205 (2003) 182

Laser processing

On the topographic and energetic surface modifications induced by laser treatment of metallic substrates before plasma spraying, M. Verdier, S. Costil, C. Coddet, R. Oltra and O. Perret 205 (2003) 3
Ablation of carbide materials with femtosecond pulses, G. Dumitru, V. Romano, H.P. Weber, M. Sentis and W. Marine 205 (2003) 80

Luminescence

Investigation of intermixing induced by sputtering and annealing in multiple quantum well, M. Ying, P. Liu, Y. Xia, X. Liu, M. Zhao, S. Xiao, Y. Sun and J. Pan 205 (2003) 182

Metals

On the topographic and energetic surface modifications induced by laser treatment of metallic substrates before plasma spraying, M. Verdier, S. Costil, C. Coddet, R. Oltra and O. Perret 205 (2003) 3

Methane oxidation

ELS and XPS study of Pd/PdO methane oxidation catalysts, G.B. Hoflund, H.A.E. Hagelin, J.F. Weaver and G.N. Salaita 205 (2003) 102

Nanostructure

Annealing amorphous carbon nanotubes for their application in hydrogen storage, L. Ci, H. Zhu, B. Wei, C. Xu and D. Wu 205 (2003) 39
Influence of surface-capping molecule exchange on the hyper-Rayleigh scattering of CdS nanoparticles, Y. Zhang, X. Wang, M. Ma, D. Fu, N. Gu, J. Liu, Z. Lu, Y. Ma, L. Xu and K. Chen 205 (2003) 256
Changeable position of SPR peak of Ag nanoparticles embedded in mesoporous SiO_2 glass by annealing treatment, A. Pan, Z. Yang, H. Zheng, F. Liu, Y. Zhu, X. Su and Z. Ding 205 (2003) 323

Optical properties

Study of the influence of annealing on the properties of CBD-CdS thin films, H. El Maliki, J.C. Bernède, S. Marsillac, J. Pinel, X. Castel and J. Pouzet 205 (2003) 65
Effects of substrate temperature on copper(II) phthalocyanine thin films, J. E, S. Kim, E. Lim, K. Lee, D. Cha and B. Friedman 205 (2003) 274

Oxides

Strontium hafnate phases by anodic spark conversion, J.P. Schreckenbach, N. Meyer, G. Marx, B.T. Lee and W.M. Kriven 205 (2003) 97
ELS and XPS study of Pd/PdO methane oxidation catalysts, G.B. Hoflund, H.A.E. Hagelin, J.F. Weaver and G.N. Salaita 205 (2003) 102

Palladium

ELS and XPS study of Pd/PdO methane oxidation catalysts, G.B. Hoflund, H.A.E. Hagelin, J.F. Weaver and G.N. Salaita 205 (2003) 102

Photoelectron spectroscopy

Study of the influence of annealing on the properties of CBD-CdS thin films, H. El Maliki, J.C. Bernède, S. Marsillac, J. Pinel, X. Castel and J. Pouzet 205 (2003) 65
ELS and XPS study of Pd/PdO methane oxidation catalysts, G.B. Hoflund, H.A.E. Hagelin, J.F. Weaver and G.N. Salaita 205 (2003) 102
Adhesion and interface chemical reactions of Cu/polyimide and Cu/TiN by XPS, W.-J. Lee, Y.-S. Lee, S.-K. Rha, Y.-J. Lee, K.-Y. Lim, Y.-D. Chung and C.-N. Whang 205 (2003) 128
Effect of aging on surface chemical bonds of PTFE irradiated by low energy Ti ion, J. Zhang, X. Zhang and H. Zhou 205 (2003) 343

Plasma processing

Systematic study of amorphous hydrogenated and fluorinated carbon films, A. Lamperti and P.M. Ossi 205 (2003) 113

Plasmons

Changeable position of SPR peak of Ag nanoparticles embedded in mesoporous SiO_2 glass by annealing treatment, A. Pan, Z. Yang, H. Zheng, F. Liu, Y. Zhu, X. Su and Z. Ding 205 (2003) 323

Polymer

Adhesion and interface chemical reactions of Cu/polyimide and Cu/TiN by XPS, W.-J. Lee, Y.-S. Lee, S.-K. Rha, Y.-J. Lee, K.-Y. Lim, Y.-D. Chung and C.-N. Whang 205 (2003) 128
Effect of aging on surface chemical bonds of PTFE irradiated by low energy Ti ion, J. Zhang, X. Zhang and H. Zhou 205 (2003) 343

Quantum effects

Investigation of intermixing induced by sputtering and annealing in multiple quantum well, M. Ying, P. Liu, Y. Xia, X. Liu, M. Zhao, S. Xiao, Y. Sun and J. Pan 205 (2003) 182

Raman scattering

Systematic study of amorphous hydrogenated and fluorinated carbon films, A. Lamperti and P.M. Ossi 205 (2003) 113

Secondary ion mass spectroscopy

Systematic study of amorphous hydrogenated and fluorinated carbon films, A. Lamperti and P.M. Ossi 205 (2003) 113

Silicon oxide

Investigation of intermixing induced by sputtering and annealing in multiple quantum well, M. Ying, P. Liu, Y. Xia, X. Liu, M. Zhao, S. Xiao, Y. Sun and J. Pan 205 (2003) 182
Changeable position of SPR peak of Ag nanoparticles embedded in mesoporous SiO_2

glass by annealing treatment, A. Pan, Z. Yang, H. Zheng, F. Liu, Y. Zhu, X. Su and Z. Ding 205 (2003) 323

Silver

Changeable position of SPR peak of Ag nanoparticles embedded in mesoporous SiO_2 glass by annealing treatment, A. Pan, Z. Yang, H. Zheng, F. Liu, Y. Zhu, X. Su and Z. Ding 205 (2003) 323

Sputter deposition

Investigation of intermixing induced by sputtering and annealing in multiple quantum well, M. Ying, P. Liu, Y. Xia, X. Liu, M. Zhao, S. Xiao, Y. Sun and J. Pan 205 (2003) 182

Growth properties and structural analysis of ZnO films and of Au clusters on ZnO, M. Ay, A. Nefedov and H. Zabel 205 (2003) 329

On the non-linear *I–V* characteristics of dc magnetron sputtered TiO_2 thin films, M.D. Stamate 205 (2003) 353

Sputtering

Investigation of intermixing induced by sputtering and annealing in multiple quantum well, M. Ying, P. Liu, Y. Xia, X. Liu, M. Zhao, S. Xiao, Y. Sun and J. Pan 205 (2003) 182

Strontium

Strontium hafnate phases by anodic spark conversion, J.P. Schreckenbach, N. Meyer, G. Marx, B.T. Lee and W.M. Kriven 205 (2003) 97

Surface roughness

On the topographic and energetic surface modifications induced by laser treatment of metallic substrates before plasma spraying, M. Verdier, S. Costil, C. Coddet, R. Oltra and O. Perret 205 (2003) 3

Thin films

Comparison of properties of CdS thin films grown by two techniques, A.I. Oliva, R. Castro-Rodríguez, O. Solís-Canto, V. Sosa, P. Quintana and J.L. Peña 205 (2003) 56

Systematic study of amorphous hydrogenated and fluorinated carbon films, A. Lamperti and P.M. Ossi 205 (2003) 113

Extracting inter-diffusion parameters of TiC from AES depth profiles, H.C. Swart, A.J. Jonker, C.H. Claassens, R. Chen, L.A. Venter, P. Ramoshebe, E. Wurth, J.J. Terblans and W.D. Roos 205 (2003) 231

Growth properties and structural analysis of ZnO films and of Au clusters on ZnO, M. Ay, A. Nefedov and H. Zabel 205 (2003) 329

On the non-linear *I–V* characteristics of dc magnetron sputtered TiO_2 thin films, M.D. Stamate 205 (2003) 353

Tin oxide

Study of the influence of annealing on the properties of CBD-CdS thin films, H. El Maliki, J.C. Bernède, S. Marsillac, J. Pinel, X. Castel and J. Pouzet 205 (2003) 65

Titanium

Effect of aging on surface chemical bonds of PTFE irradiated by low energy Ti ion, J. Zhang, X. Zhang and H. Zhou 205 (2003) 343

Titanium carbide

Extracting inter-diffusion parameters of TiC from AES depth profiles, H.C. Swart, A.J. Jonker, C.H. Claassens, R. Chen, L.A. Venter, P. Ramoshebe, E. Wurth, J.J. Terblans and W.D. Roos 205 (2003) 231

Titanium Nitride

Adhesion and interface chemical reactions of Cu/polyimide and Cu/TiN by XPS, W.-J. Lee, Y.-S. Lee, S.-K. Rha, Y.-J. Lee, K.-Y. Lim, Y.-D. Chung and C.-N. Whang 205 (2003) 128

Titanium oxide

On the non-linear *I–V* characteristics of dc magnetron sputtered TiO_2 thin films, M.D. Stamate 205 (2003) 353

X-ray diffraction

Annealing amorphous carbon nanotubes for their application in hydrogen storage, L. Ci, H. Zhu, B. Wei, C. Xu and D. Wu 205 (2003) 39

Comparison of properties of CdS thin films grown by two techniques, A.I. Oliva, R.

Castro-Rodríguez, O. Solís-Canto, V. Sosa, P. Quintana and J.L. Peña 205 (2003) 56
Study of the influence of annealing on the properties of CBD-CdS thin films, H. El Maliki, J.C. Bernède, S. Marsillac, J. Pinel, X. Castel and J. Pouzet 205 (2003) 65
Effects of substrate temperature on copper(II) phthalocyanine thin films, J. E, S. Kim, E. Lim, K. Lee, D. Cha and B. Friedman 205 (2003) 274
Growth properties and structural analysis of ZnO films and of Au clusters on ZnO, M. Ay, A. Nefedov and H. Zabel 205 (2003) 329

X-ray scattering

Growth properties and structural analysis of ZnO films and of Au clusters on ZnO, M. Ay, A. Nefedov and H. Zabel 205 (2003) 329

Zinc oxide

Growth properties and structural analysis of ZnO films and of Au clusters on ZnO, M. Ay, A. Nefedov and H. Zabel 205 (2003) 329